

Notice of References Cited	Application/Control No. 10/065,482	Applicant(s)/Patent Under Reexamination CHEN ET AL.	
	Examiner Satish S. Rampuria	Art Unit 2191	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0023966 A1	01-2003	Shimizu et al.	717/175
*	B	US-2005/0160195 A1	07-2005	Bruner et al.	710/008
*	C	US-2003/0088868 A1	05-2003	Chang et al.	717/173
*	D	US-2005/0044278 A1	02-2005	Goodman et al.	710/001
*	E	US-6,662,314 B1	12-2003	Iwata et al.	714/42
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.